


<b>Search Notes</b> 	<b>Application/Control No.</b> 10725502	<b>Applicant(s)/Patent Under Reexamination</b> FUJITA ET AL.
	<b>Examiner</b> Shih, Haoshian	<b>Art Unit</b> 2173

SEARCHED			
Class	Subclass	Date	Examiner
715	781, 764, 788, 790	4/23/2007	HSS
345	173	4/23/2007	HSS

SEARCH NOTES		
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner